## Notice of References Cited Application/Control No. 10/532,582 Examiner DON N. VO Applicant(s)/Patent Under Reexamination CHEN ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,970,496	11-2005	Ben-Bassat et al.	375/141
*	В	US-2003/0002471	01-2003	Crawford et al.	370/343
*	Ç	US-2006/0056541	03-2006	Chen et al.	375/316
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	7	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## NON-PATENT DOCUMENTS

	TOTAL								
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)							
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	x								

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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